

# MT4237

## 40V Complementary Power MOSFET

### Features

- N-Channel  
40V/5.0A  
 $R_{DS(ON)} = 25m\Omega$  (typ) @  $V_{GS} = 10V$   
 $R_{DS(ON)} = 33m\Omega$  (typ) @  $V_{GS} = 4.5V$
- P-Channel  
-40V/-4.0A  
 $R_{DS(ON)} = 44m\Omega$  (typ) @  $V_{GS} = -10V$   
 $R_{DS(ON)} = 57m\Omega$  (typ) @  $V_{GS} = -4.5V$
- RoHS Compliant

### General Description

This complementary MOSFET device is produced using Mos-tech's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

### Applications

- DC-DC converter
- Power management
- LCD backlight inverter

### Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	N-CH	P-CH	Units
V <sub>DSS</sub>	Drain-Source Voltage	40	-40	V
V <sub>GSS</sub>	Gate-Source Voltage	± 20	± 20	V
I <sub>D</sub>	Drain Current   - Continuous			

### Thermal Characteristics

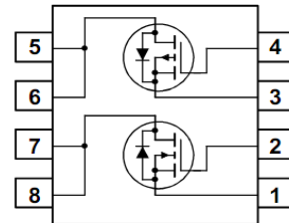
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	80	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	55	$^\circ\text{C/W}$



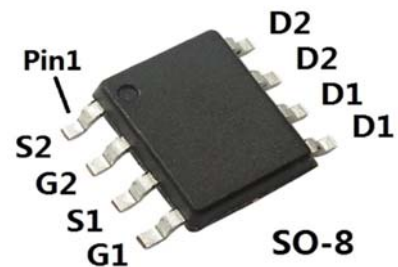
**MT Semiconductor®**

<http://www.mtsemi.com>

### Simplified Schematic



### MARKING DIAGRAM & PIN ASSIGNMENT



# Electrical Characteristics T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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## Off Characteristics

BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA V <sub>GS</sub> = 0 V, I <sub>D</sub> = -250 μA	N-CH P-CH	40 -40	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C I <sub>D</sub> = -250 μA, Referenced to 25°C	N-CH P-CH	-	21 -13	-	mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = -40V, V <sub>GS</sub> = 0 V	N-CH P-CH	-	-	1 -1	μA
I <sub>GSS</sub>	Gate-Body Leakage	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	N-CH P-CH	-	-	±100 ±100	nA

## On Characteristics (Note 2)

V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μA	N-CH P-CH	1 -1	1.7 -1.5	2.5 -2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C I <sub>D</sub> = -250 μA, Referenced to 25°C	N-CH P-CH	-	-3.6 -3.6	-	mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 2.5A V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 2.0A	N-CH	- -	25 33	35 45	mΩ
		V <sub>GS</sub> = -10V, I <sub>D</sub> = -2.5A V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -2.0A	P-CH	- -	44 57	60 78	
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 5 V V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -5 V	N-CH P-CH	2.5 -2	-	-	A
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4.5 A V <sub>DS</sub> = -5 V, I <sub>D</sub> = -3.5 A	N-CH P-CH	-	15 12	-	S

## Dynamic Characteristics

C <sub>iss</sub>	Input Capacitance	N-CH V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	N-CH P-CH	- -	315 55	-	pF
C <sub>oss</sub>	Output Capacitance	P-CH	N-CH P-CH	- -	40 19	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	N-CH P-CH	- -	68 32	-	pF

## Switching Characteristics (Note 2)

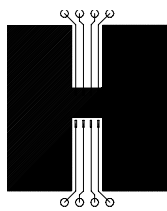
t <sub>d(on)</sub>	Turn-On Delay Time	N-CH V <sub>DD</sub> = 10 V, I <sub>D</sub> = 1 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 1 Ω	N-CH P-CH	- -	3 5	-	ns
t <sub>r</sub>	Turn-On Rise Time		N-CH P-CH	- -	7.5 12	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	P-CH V <sub>DD</sub> = -10 V, I <sub>D</sub> = -1 A, V <sub>GS</sub> = -10 V, R <sub>GEN</sub> = 1 Ω	N-CH P-CH	- -	20 25	-	ns
t <sub>f</sub>	Turn-Off Fall Time		N-CH P-CH	- -	6 10	-	ns
Q <sub>g</sub>	Total Gate Charge	N-CH V <sub>DS</sub> = 10 V, I <sub>D</sub> = 4.5 A, V <sub>GS</sub> = 10 V	N-CH P-CH	- -	10 30	-	nC
Q <sub>gs</sub>	Gate-Source Charge	P-CH	N-CH P-CH	- -	1 0.8	-	nC
Q <sub>gd</sub>	Gate-Drain Charge	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -3.5 A, V <sub>GS</sub> = -10V	N-CH P-CH	- -	2 1.8	-	nC

**Electrical Characteristics (continued)** $T_A = 25^\circ\text{C}$  unless otherwise noted

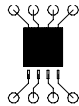
Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>							
$I_S$	Maximum Continuous Drain-Source Diode Forward Current		N-CH P-CH	-	-	1.4 -1.4	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 1\text{ A}$ (Note 2) $V_{GS} = 0\text{ V}, I_S = -3.5\text{ A}$ (Note 2)	N-CH P-CH	-	0.8 -0.9	-	V

**Notes:**

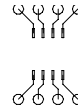
1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a)  $78^\circ\text{C/W}$  when mounted on a  $0.5\text{ in}^2$  pad of 2 oz copper



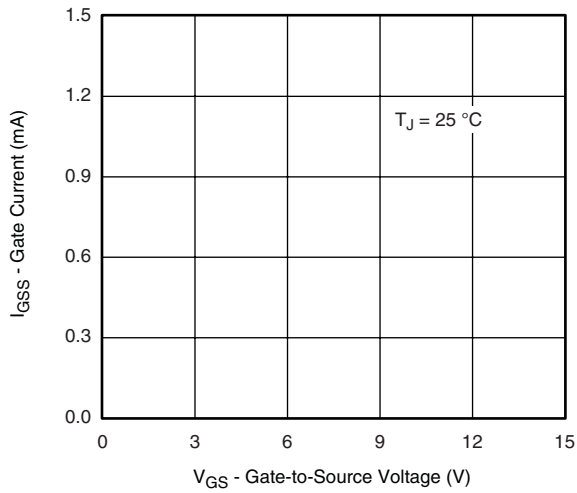
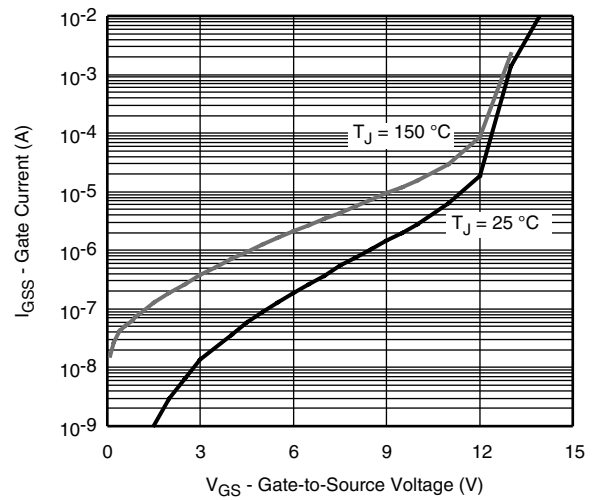
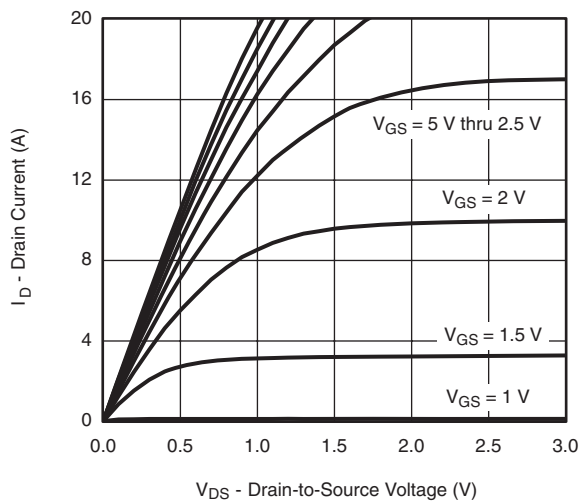
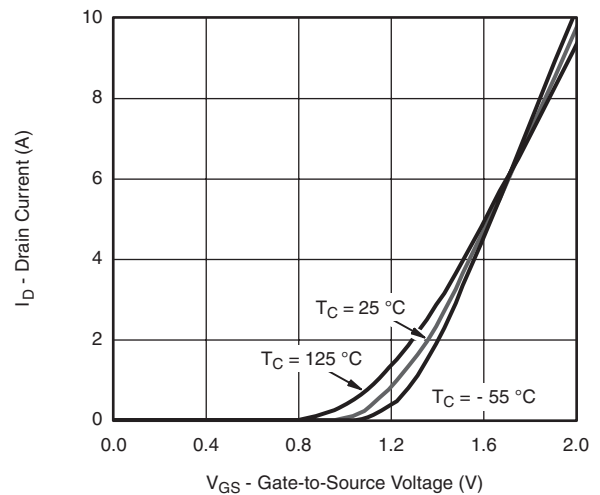
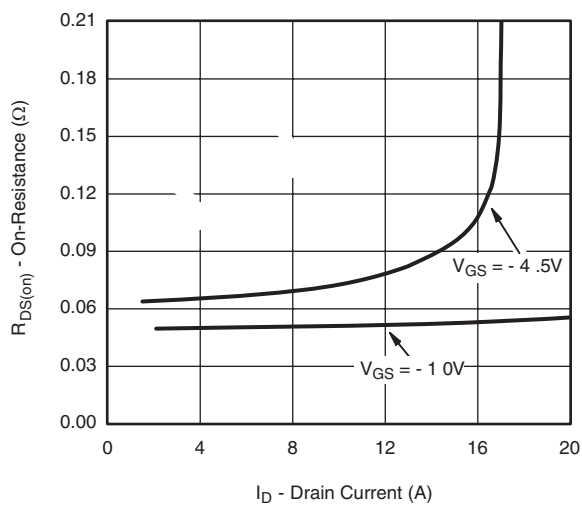
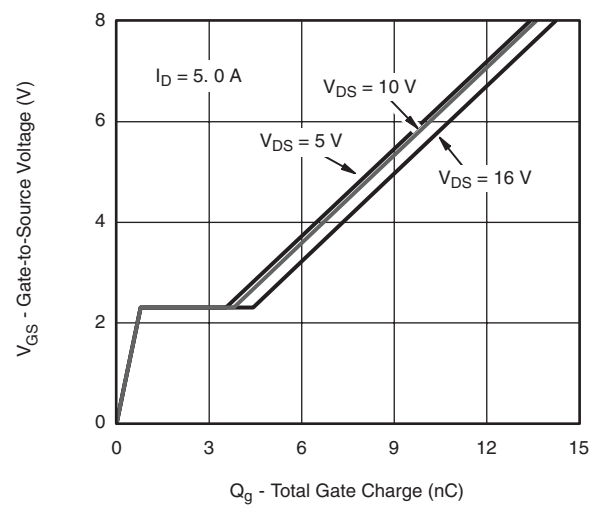
b)  $125^\circ\text{C/W}$  when mounted on a  $.02\text{ in}^2$  pad of 2 oz copper

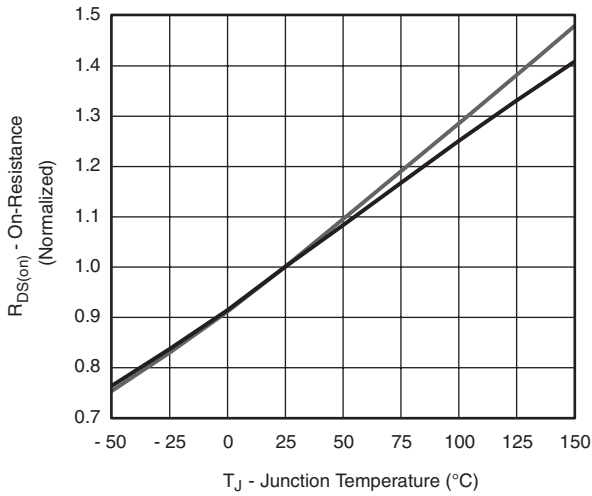


c)  $135^\circ\text{C/W}$  when mounted on a minimum pad.

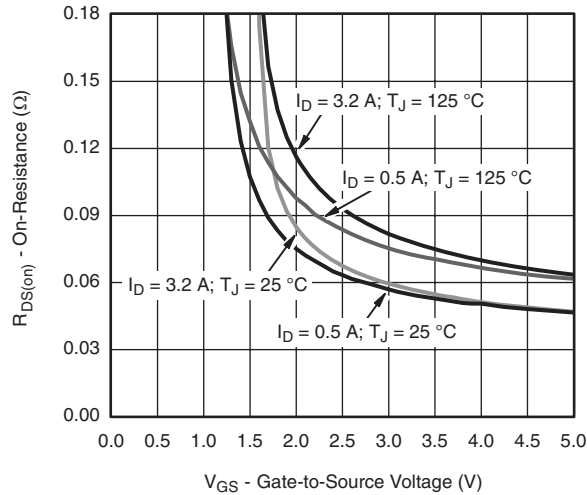
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $< 300\mu\text{s}$ , Duty Cycle  $< 2.0\%$

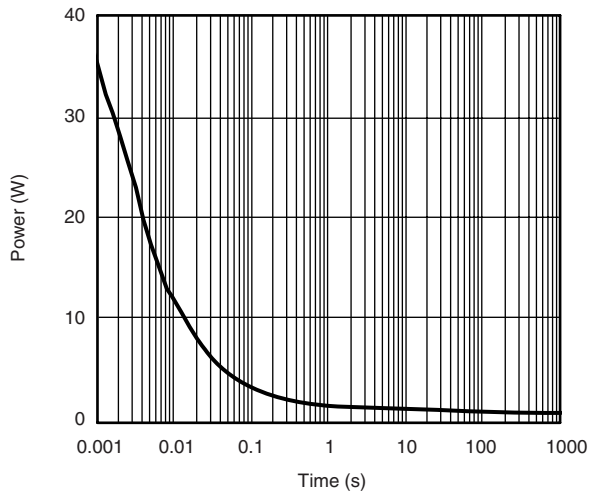
**TYPICAL CHARACTERISTICS P-CH****Figure 1 Gate Current vs. Gate-Source Voltage****Figure 2 Gate Current vs. Gate-Source Voltage****Figure 3 Output Characteristics****Figure 4 Transfer Characteristics****Figure 5 On-Resistance vs. Drain Current****Figure 6 Gate Charge**



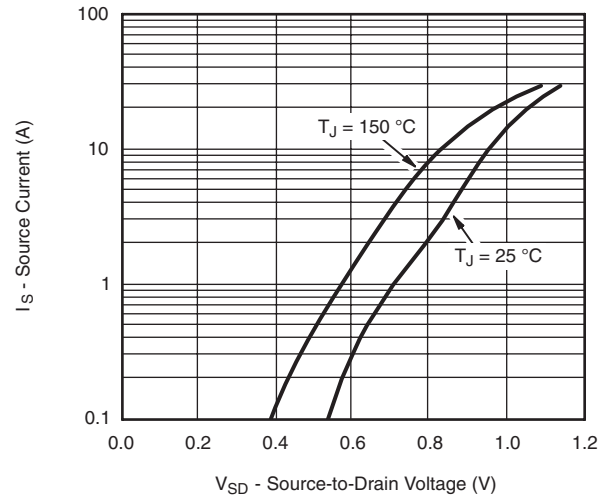
**Figure 7 On-Resistance vs. Junction Temperature**



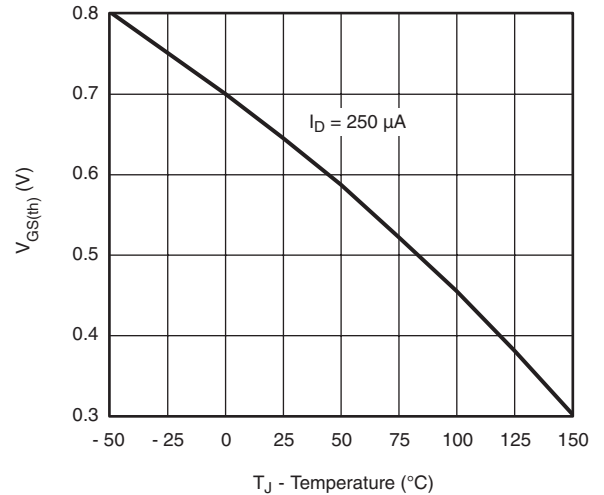
**Figure 9 On Resistance VS. Gate-to-Source Voltage**



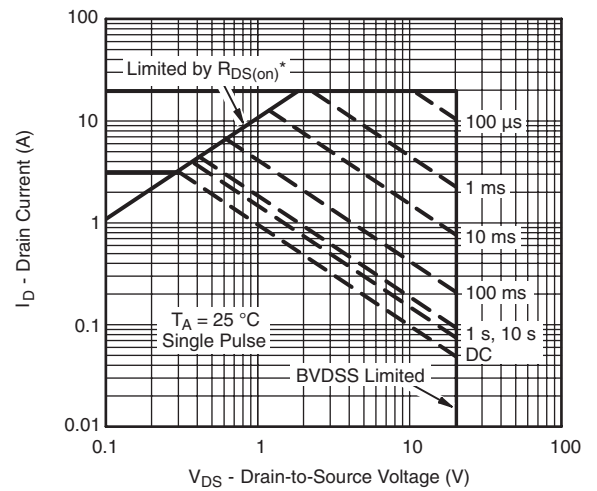
**Figure 11 Single Pulse Power, Junction-to-Ambient**



**Figure 8 Source-Drain Diode Forward Voltage**

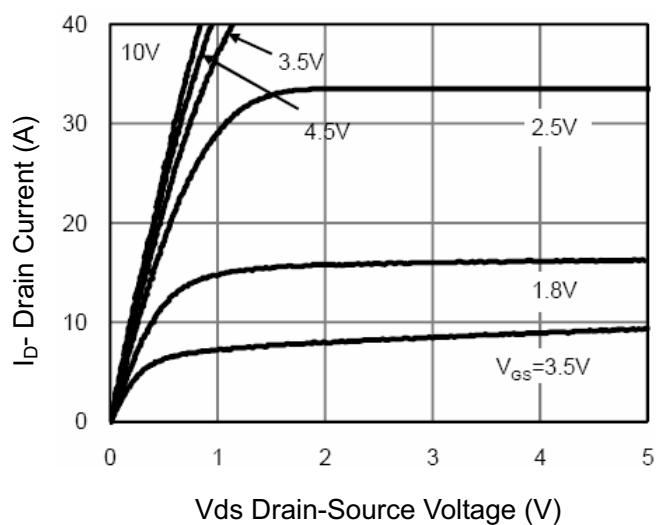


**Figure 10 Threshold Voltage**

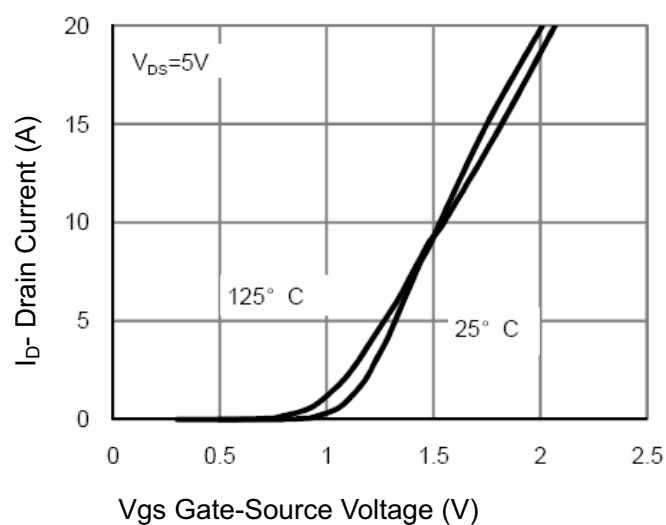


**Figure 12 Safe Operating Area, Junction-to-Ambient**

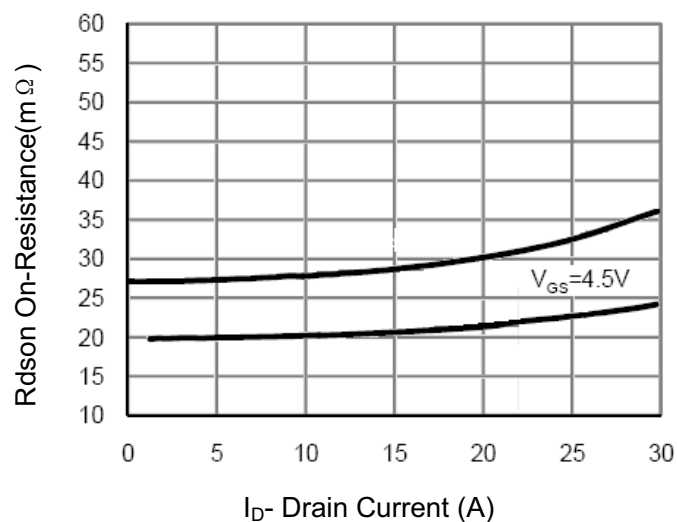
### Typical Characteristics: N-CH



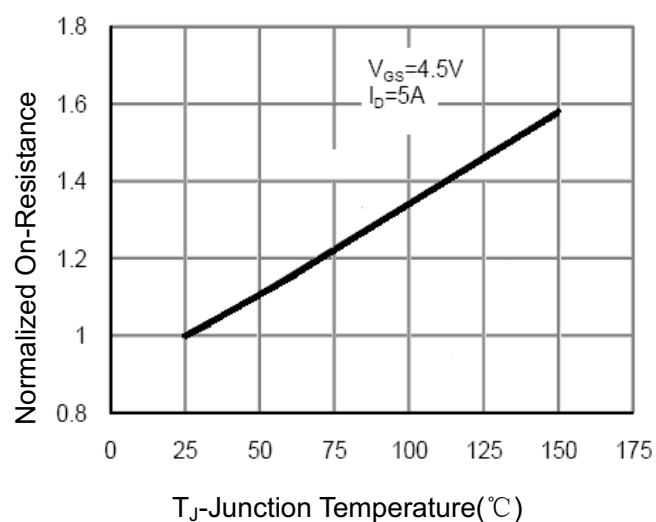
**Figure 1 Output Characteristics**



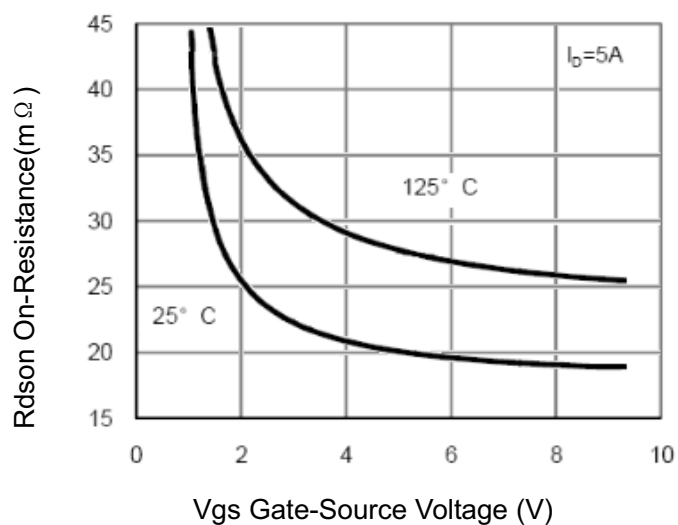
**Figure 2 Transfer Characteristics**



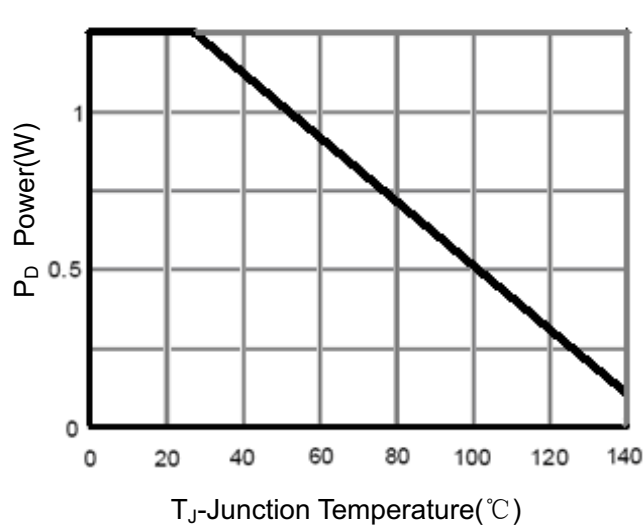
**Figure 3 Drain-Source On-Resistance**



**Figure 4 Drain-Source On-Resistance**



**Figure 5 Rdson vs Vgs**



# Typical Characteristics: N-CH

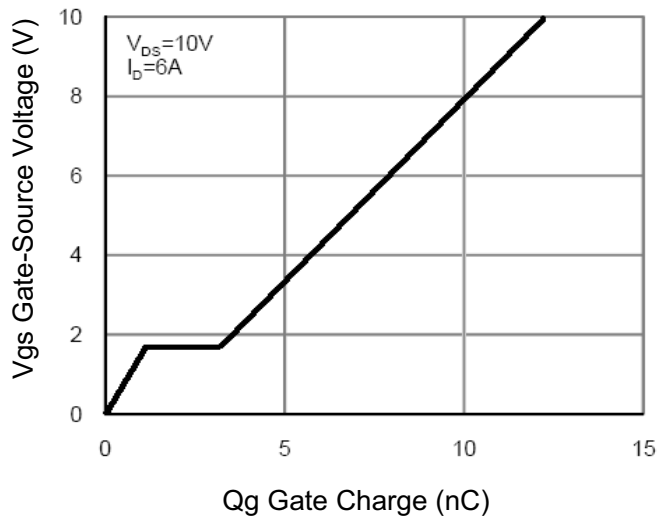


Figure 7 Gate Charge

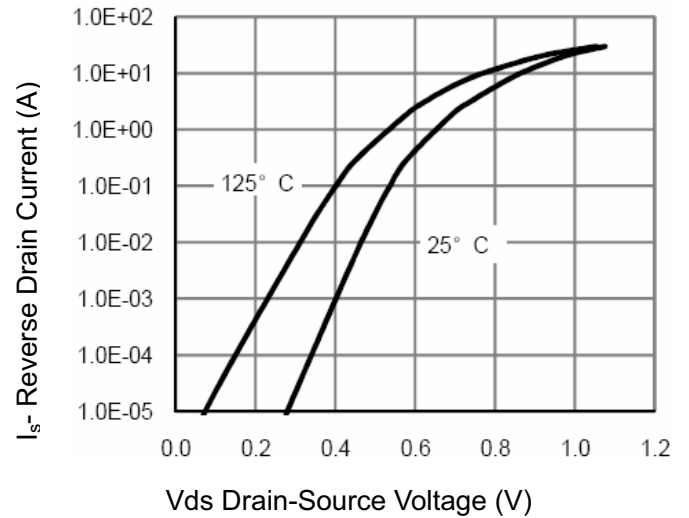


Figure 8 Source- Drain Diode Forward

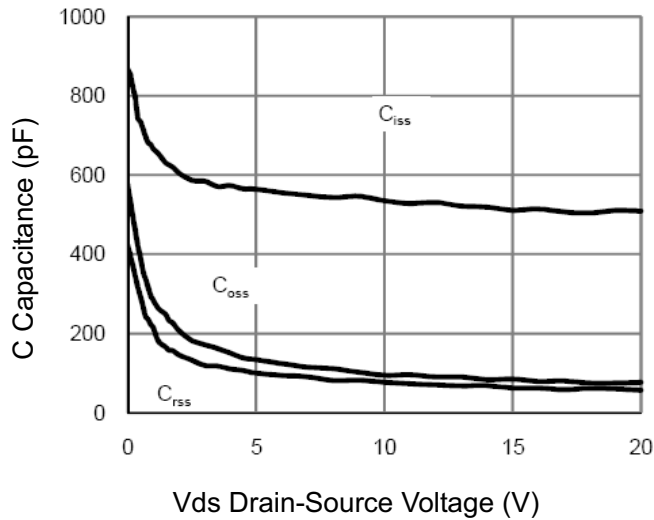


Figure 9 Capacitance vs Vds

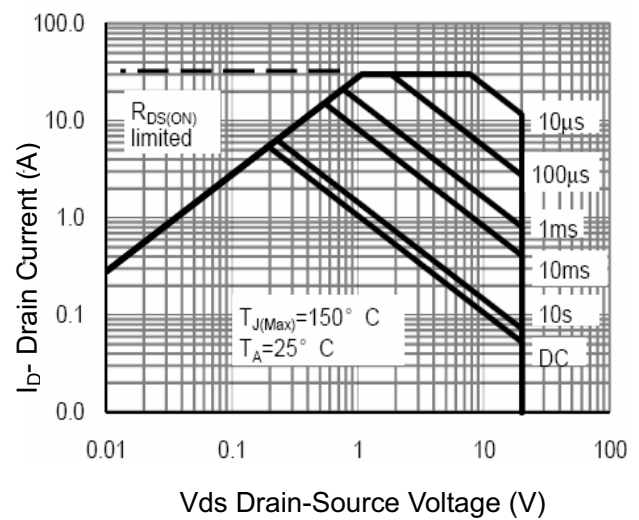


Figure 10 Safe Operation Area

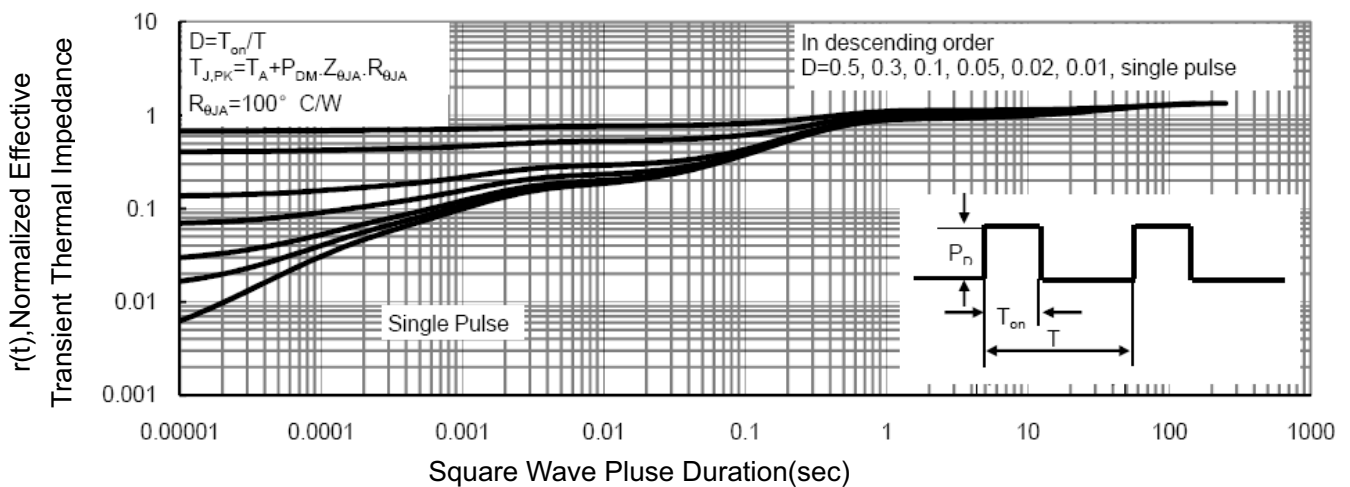
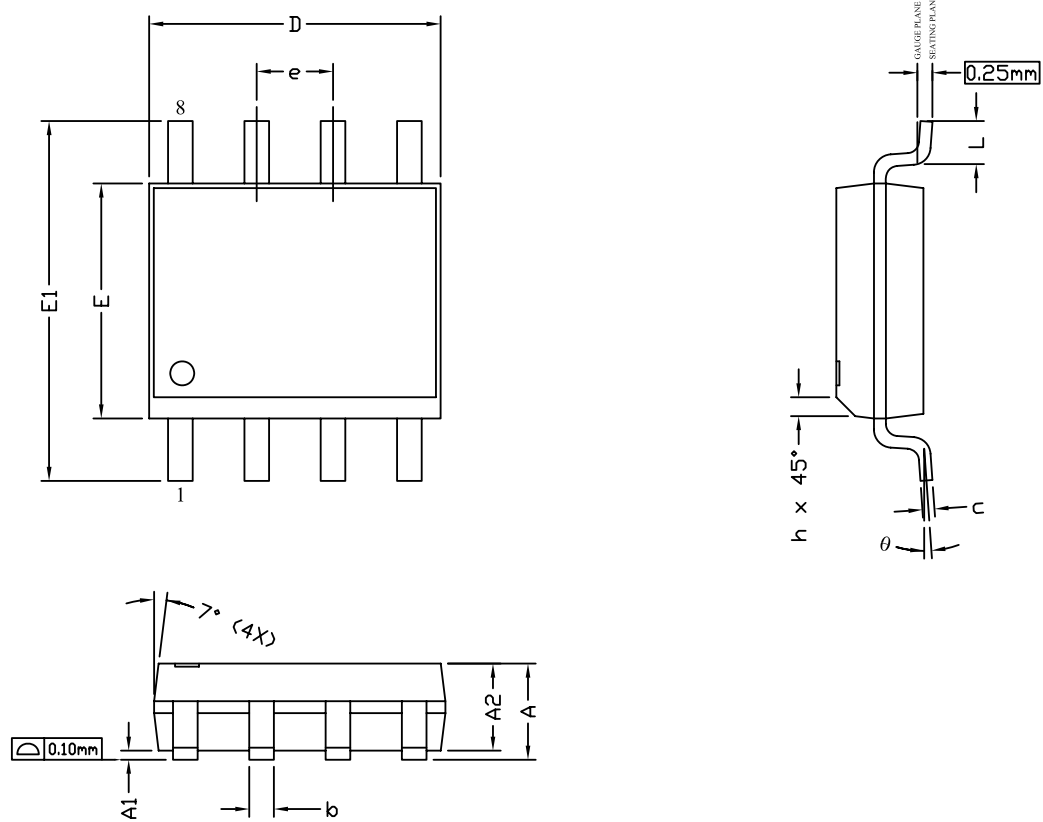


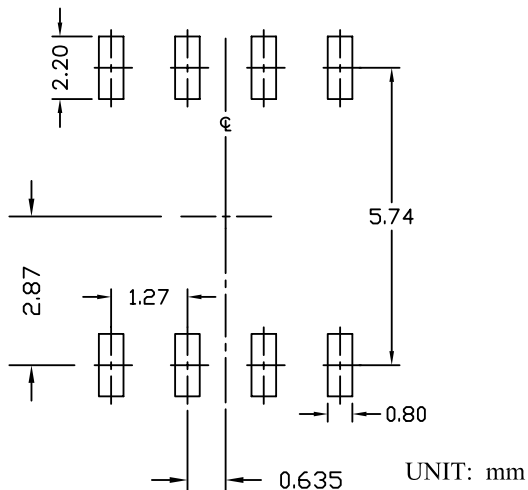
Figure 11 Normalized Maximum Transient Thermal Impedance

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Version	rev H

## S08 PACKAGE OUTLINE



## RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.35	1.65	1.75	0.053	0.065	0.069
A1	0.10	—	0.25	0.004	—	0.010
A2	1.25	1.50	1.65	0.049	0.059	0.065
b	0.31	—	0.51	0.012	—	0.020
c	0.17	—	0.25	0.007	—	0.010
D	4.80	4.90	5.00	0.189	0.193	0.197
E	3.80	3.90	4.00	0.150	0.154	0.157
e	1.27 BSC			0.050 BSC		
E1	5.80	6.00	6.20	0.228	0.236	0.244
h	0.25	—	0.50	0.010	—	0.020
L	0.40	—	1.27	0.016	—	0.050
$\theta$	$0^\circ$	—	$8^\circ$	$0^\circ$	—	$8^\circ$

### NOTE

1. ALL DIMENSIONS ARE IN MILLIMETERS.
2. DIMENSIONS ARE INCLUSIVE OF PLATING.
3. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.  
MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
4. DIMENSION L IS MEASURED IN GAUGE PLANE.
5. CONTROLLING DIMENSION IS MILLIMETER.  
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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